

Abstracts

Noise Performance of Microwave HEMT

K. Joshin, T. Mimura, M. Niori, Y. Yamashita, K. Kosemura and J. Saito. "Noise Performance of Microwave HEMT." 1983 MTT-S International Microwave Symposium Digest 83.1 (1983 [MWSYM]): 563-565.

Low noise HEMTs (High Electron Mobility Transistors) with 0.5 μ m gate have been made using direct electron beam lithography. At 12 GHz a noise figure of 1.4 dB with an associated gain of 11 dB has been obtained at room temperature. Noise figure has been reduced to 0.35 dB by decreasing ambient temperature to 100K.

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